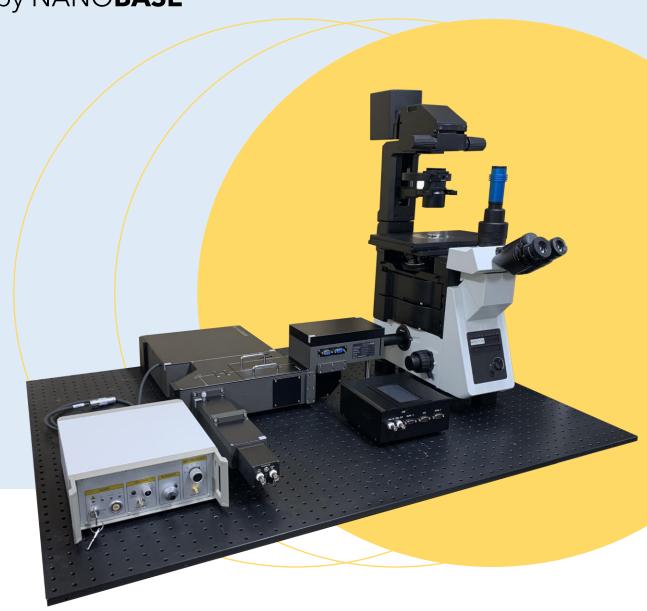
XPER FLIM

The only system of choice for time-resolved photoluminescence of both value and performance by NANOBASE





APPLICATION

What is TRPL, FLIM, and TCSPC?

Time-Resolved Photoluminescence (TRPL) is a general term while Fluorescence Lifetime Imaging (FLIM) or Time-Correlated Single Photon Counting (TCSPC) are special techniques to achieve TRPL.

Fluorescence lifetime imaging (FLIM) yields images with the intensity of each pixel determined by τ , which allows researchers to view contrast between materials with different fluorescence decay rates, and also produces images which show changes in other decay pathways.

Fluorescence lifetimes can be determined in the time domain by using a pulsed source. When a population of fluorophores is excited by an ultrashort or delta pulse of light, the time-resolved fluorescence will decay exponentially.

Time-correlated single-photon counting (TCSPC) is usually employed as a measurement method because it compensates for variations in source intensity and single photon pulse amplitudes. More specifically, TCSPC records times at which individual photons are usually detected by a single photon avalanche photo diode (SPAD) with respect to the excitation laser pulse.

The recordings are repeated for multiple laser pulses, and after enough recorded events, researchers are able to build a histogram of the number of events across all of these recorded time points. This histogram can then be fit to an exponential function that contains the exponential lifetime decay function of interest, and the lifetime parameter can accordingly be extracted.

Xper-FLIM is equipped with the single-photon avalanche diode (SPAD) and the time tagging electronics and can offer options of detection channels at a low-cost, realizing super fast analysis for TRPL researchers. Xper-FLIM is also available in either an inverted microscope or an upright microscope to meet a recently growing number of various application needs.



Biology/Medical Research

- Molecular biological analysis
- Biochemical analysis



Semiconductors

Monitoring and analysis of wafer quality



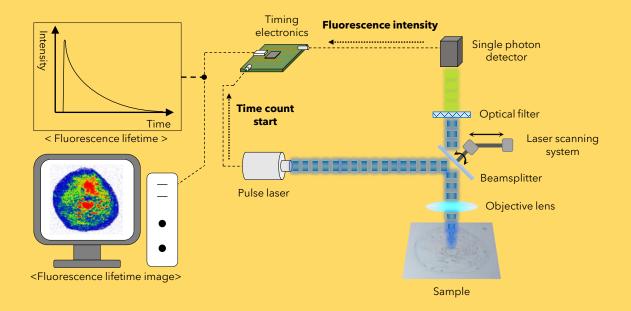
Photoelectron Materials

Efficiency analysis of LED, OLED

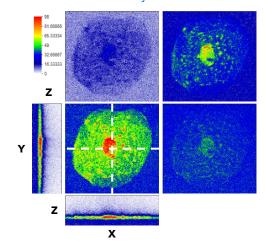


Solar Cells

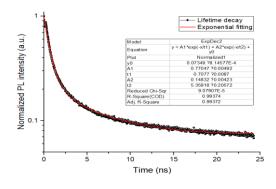
Efficiency analysis of injection



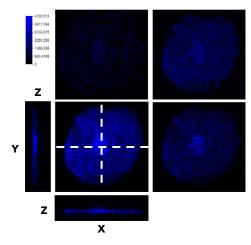
3-dimensional fluorescence intensity*



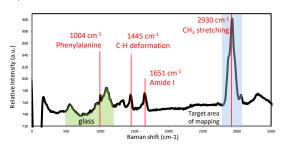
Lifetime decay of nucleus area*



Raman intensity mapping image*



Averaged Raman spectrum*



Microscope

- Reflected LED illuminator for bright field
- Mechanical X-Y stage with right-hand control Motorized control of Z-axis position (optional)
- Includes main frame, stage plate, quintuple revolving nosepiece, and control box
- 40X objective (other options: 10X, 20X, 50X, and 100X)
- Upright or inverted microscope

Laser Scanning Module and Vision Camera

- Wavelength range: 400~1000 nmLaser scanning mode: Raster scan
- Scanning area: 200 μm ×200 μm (when using a 40X objective lens)
- Includes a 6 MP camera for optical image acquisition (FOV: 330 μm × 220 μm when using 40X)
- A controller is included (USB)
- Maximum scan speed: >100 lines/s

Laser

Picosecond pulsed diode laser and driver

- Wavelength: 390 ~ 700 nm
- Freespace / Fiber coupling selection (optional)

Optical Filter

Choose filters corresponding to laser wavelength

- Wavelength range: 390 ~ 700 nm
- Interchangeable in a filter box for corresponding lasers

System Platform

- 1 slot to insert a laser neutral density (ND) filter or a polarizer
- 2 slots to insert polarizers or waveplates
- 1 slot to insert an interchangeable filter set
- Up to 3 lasers are installable.
- Fiber coupling port is installable. (optional)
- Provides a robust platform for stable beam alignment

Detector

Photon detection efficiency

- 24 % at 400 nm Active area diameter : 50 μm
- 49 % at 550 nm
 37 % at 650 nm
 Uark counts: <250, <100, <50, <25 cps
 (depending on grade of detector)
 - NIM timing output: 50 ps
 After-pulsing probability: <3%

Laser Driver

- Repetition rate: 31.25 kHz ~ 80 MHz
- Trigger: Level -1 to +1 V (adjustable)
- Frequency range: 10 Hz ~ 80 MHz
- Synchronization output: Amplitude < 0.8 mV into 50 Ohms

Electronics

Time-tagging electronics

- Detection channels: 1 or 2Time range: 25 ps
- Trigger: 0~ -1200 mV
 Count rate: 40 MHz
- Count rate: 40 Mi
 Marker: TTL x4

NanoSpectrum Software Suite

- Fluorescence lifetime acquisition & imaging
- Spectrum data export format: .txt, .csv
- 2D mapping data export format: .spm, .csv

Specifications are subject to change without notice.

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Xper-FLIM - Cat. No. : XPER-FLIM

- Functionalities : TRPL measurements only

XperRF - Cat. No. : XPERRF

- Functionalities : TRPL + Raman measurements

NANOBASE